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Substitute for form 1449A/B/PTO  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  <i>(Use as many sheets as necessary)</i>				<b>Complete If Known</b>	
				Application Number	NEW
				Filing Date	August 16, 2006
				First Named Inventor	Yusuke YAMADA
				Art Unit	N/A
				Examiner Name	Not Yet Assigned
				Attorney Docket Number	0033-1093PUS1
Sheet	1	of	1		

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	AA*	US-2003/0204660-A1	10-30-2003	SAITO et al.	
	AB*	US-6,701,371-B1	03-02-2004	LEE	
	AC*	US-2002/0048258-A1	04-25-2002	OYAMA	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>
	BA	JP-2003-283499-A	10-03-2003			ABS
	BB	JP-2000-134278-A	05-12-2000			ABS
	BC	JP-2002-124981-A	04-26-2002			ABS
	BD	JP-2002-247067-A	08-30-2002			ABS

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NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
	CA	MATSUE et al., IDG Japan, March 29, 2003, pages 66-122.	Par. Trans.

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Examiner Signature	/Leon Andrews/	Date Considered	07/31/2009
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